















ESD

TVS

MOS

LDO

Diode

Sensor

DC-DC

Product Specification

Domestic Part Number	IRFZ34N
Overseas Part Number	IRFZ34N
▶ Equivalent Part Number	IRFZ34N





- ★ Super Low Gate Charge
- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

Product Summary

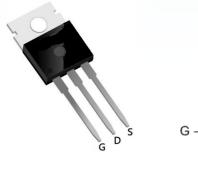
BVDSS	RDSON	ID
60V	30mΩ	30A

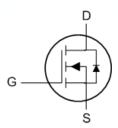
Description

The IRFZ34N is the high cell density trenched N-ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The IRFZ34N meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

TO220 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	30	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	19	А
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	5.6	А
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	4.5	А
I _{DM}	Pulsed Drain Current ²	70	А
EAS	Single Pulse Avalanche Energy ³	34.5	mJ
las	Avalanche Current	22.6	А
P _D @T _C =25°C	Total Power Dissipation⁴	58	W
P _D @T _A =25°C	Total Power Dissipation⁴	2	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R ₀ JA	Thermal Resistance Junction-Ambient ¹		62	°C/W
R _θ JC	Thermal Resistance Junction-Case ¹		2.16	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.063		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =12A			30	mΩ
R _{DS(ON)}		V _{GS} =4.5V , I _D =10A			38	
$V_{GS(th)}$	Gate Threshold Voltage	V V I- 2500A	1.2		2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	──V _{GS} =V _{DS} , I _D =250uA		-5.24		mV/°C
lass	Drain Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =25°C			1	
IDSS	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =55°C			5	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =12A		17		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		3.2	6.4	Ω
Qg	Total Gate Charge (4.5V)	V _{DS} =48V , V _{GS} =4.5V , I _D =10A		12.6		
Q_gs	Gate-Source Charge			3.2		nC
Q_{gd}	Gate-Drain Charge			6.3		
T _{d(on)}	Turn-On Delay Time			8		
Tr	Rise Time	V_{DD} =30V , V_{GS} =10V , R_{G} =3.3 Ω ,		14.2		ns
T _{d(off)}	Turn-Off Delay Time	I _D =10A		24.4		115
T _f	Fall Time			4.6		
Ciss	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		1378		
Coss	Output Capacitance			86		pF
C _{rss}	Reverse Transfer Capacitance			64		

Diode Characteristics

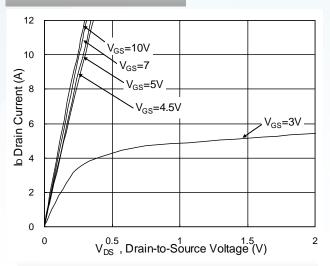
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			30	Α
I _{SM}	Pulsed Source Current ^{2,5}				60	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

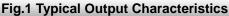
Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=22.6A
- 4.The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.



Typical Characteristics





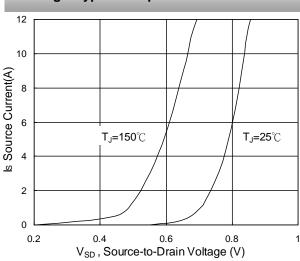


Fig.3 Forward Characteristics of Reverse

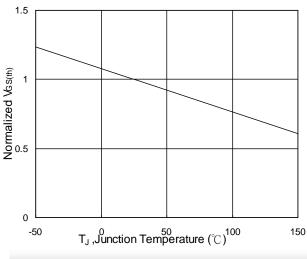


Fig.5 Normalized V_{GS(th)} v.s T_J

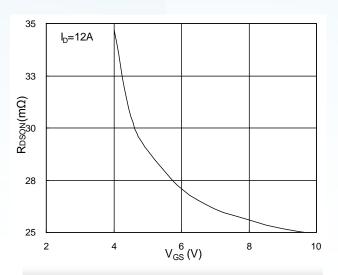


Fig.2 On-Resistance v.s Gate-Source

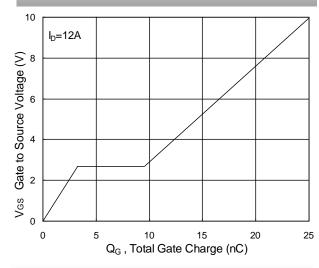


Fig.4 Gate-Charge Characteristics

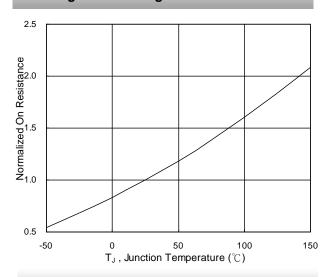
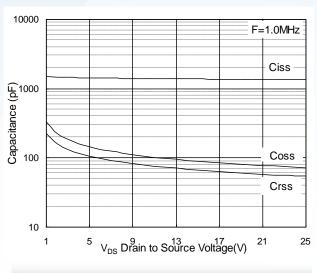


Fig.6 Normalized R_{DSON} v.s T_J





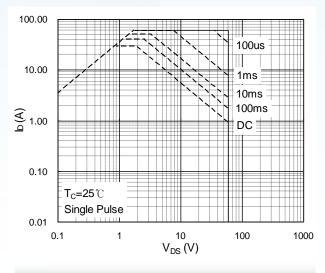


Fig.7 Capacitance

Fig.8 Safe Operating Area

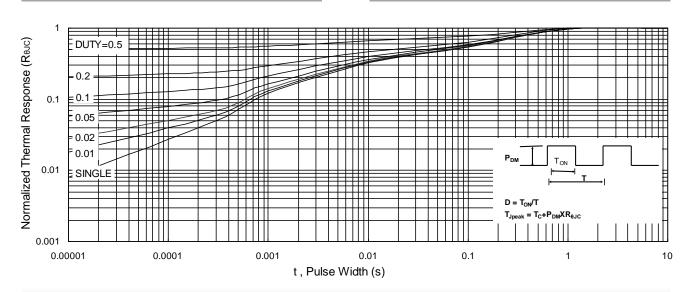
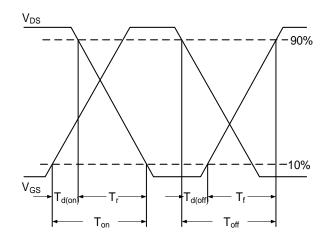


Fig.9 Normalized Maximum Transient Thermal Impedance



E A S = 1/2 L x₈ 1 x B V₆

B V₆ - V₀

V_D

V_S

Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Waveform



Disclaimer

EVVOSEMI ("EVVO") reserves the right to make corrections, enhancements, improvements, and other changes to its products and services at any time, and to discontinue any product or service without notice.

EVVO warrants the performance of its hardware products to the specifications applicable at the time of sale in accordance with its standard warranty. Testing and other quality control techniques are used as deemed necessary by EVVO to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

Customers should obtain and confirm the latest product information and specifications before final design, purchase, or use. EVVO makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does EVVO assume any liability for application assistance or customer product design. EVVO does not warrant or accept any liability for products that are purchased or used for any unintended or unauthorized application.

EVVO products are not authorized for use as critical components in life support devices or systems without the express written approval of EVVOSEMI.

The EVVO logo and EVVOSEMI are trademarks of EVVOSEMI or its subsidiaries in relevant jurisdictions. EVVO reserves the right to make changes without further notice to any products herein.